

U74LVC34A

CMOS IC

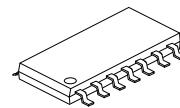
HEX BUFFER

■ DESCRIPTION

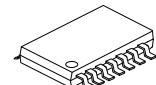
The **U74LVC34A** is a hex buffer device providing, it provides the function Y = A.

■ FEATURES

- * Operation voltage range: 1.65~5.5V
- * Low Power Dissipation
- * 24mA Output Drive ($V_{CC}=3.3V$)
- * High Noise Immunity
- * Power Down Protection



SOP-14U

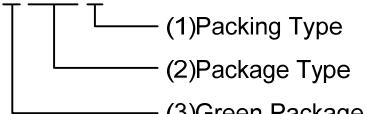


TSSOP-14U

■ ORDERING INFORMATION

Ordering Number		Package	Packing
Lead Free	Halogen Free		
U74LVC34AL-UEA-R	U74LVC34AG-UEA-R	SOP-14U	Tape Reel
U74LVC34AL-UEB-R	U74LVC34AG-UEB-R	TSSOP-14U	Tape Reel

U74LVC34AG-UEA-R



(1)Packing Type

(2)Package Type

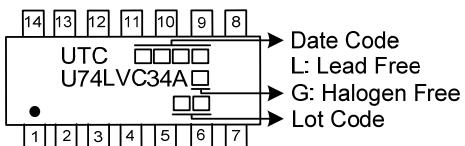
(3)Green Package

(1) R: Tape Reel

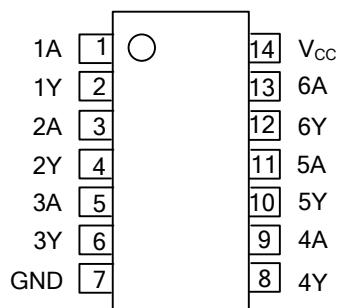
(2) UEA: SOP-14U, UEB: TSSOP-14U

(3) G: Halogen Free and Lead Free, L: Lead Free

■ MARKING



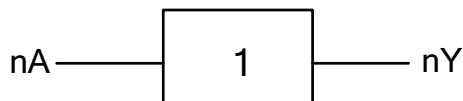
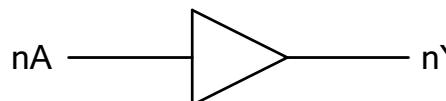
■ PIN CONFIGURATION



■ FUNCTION TABLE (Each Gate)

INPUT(A)	OUTPUT(Y)
L	L
H	H

■ LOGIC DIAGRAM (Each Gate)



IEC Logic Symbol

■ ABSOLUTE MAXIMUM RATING (Unless otherwise specified)

PARAMETER	SYMBOL	RATINGS	UNIT
Supply Voltage	V _{CC}	-0.5~6.5	V
Input Voltage	V _{IN}	-0.5~6.5	V
Output Voltage (active mode)	V _{OUT}	-0.5~V _{CC} +0.5	V
Output Voltage (power-down mode)	V _{OUT}	-0.5~6.5	V
Input Clamp Current (V _{IN} <0)	I _{IK}	-50	mA
Output Clamp Current (V _O <0)	I _{OK}	-50	mA
Output Current	I _{OUT}	±50	mA
V _{CC} or GND Current	I _{CC}	±100	mA
Storage Temperature	T _{STG}	-65 ~ +150	°C

Note: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

■ RECOMMENDED OPERATING CONDITIONS (Unless otherwise specified)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNIT
Supply Voltage	V _{CC}	Operating	1.65		5.5	V
		Data retention only	1.5			V
Input Voltage	V _{IN}		0		5.5	V
Output Voltage	V _{OUT}		0		V _{CC}	V
Input Transition Rise or Fall Rate	t _R / t _F	V _{CC} =1.8V±0.15V, 2.5V±0.2V			20	ns/V
		V _{CC} =3.3V±0.3V			10	ns/V
		V _{CC} =5V±0.5V			5	ns/V
Operating Temperature	T _A		-40		+125	°C

■ STATIC CHARACTERISTICS (Unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
High-Level Input Voltage	V _{IH}	V _{CC} =1.65~1.95V	0.65×V _{CC}			V
		V _{CC} =2.3~2.7V	1.7			
		V _{CC} =2.7~3.6V	2			
		V _{CC} =4.5~5.5V	0.7×V _{CC}			
Low-Level Input Voltage	V _{IL}	V _{CC} =1.65~1.95V			0.35×V _{CC}	V
		V _{CC} =2.3~2.7V			0.7	
		V _{CC} =2.7~3.6V			0.8	
		V _{CC} =4.5~5.5V			0.3×V _{CC}	
High-Level Output Voltage	V _{OH}	V _{CC} =1.65~5.5V, I _{OH} =-100mA	V _{CC} -0.1			V
		V _{CC} =1.65V, I _{OH} =-4mA	1.2			
		V _{CC} =2.3V, I _{OH} =-8mA	1.9			
		V _{CC} =3V, I _{OH} =-16mA	2.4			
		V _{CC} =3V, I _{OH} =-24mA	2.3			
		V _{CC} =4.5V, I _{OH} =-32mA	3.8			
Low-Level Output Voltage	V _{OL}	V _{CC} =1.65~5.5V, I _{OL} =100mA			0.1	V
		V _{CC} =1.65V, I _{OL} =4mA			0.45	
		V _{CC} =2.3V, I _{OL} =8mA			0.3	
		V _{CC} =3V, I _{OL} =16mA			0.4	
		V _{CC} =3V, I _{OL} =24mA			0.55	
		V _{CC} =4.5V, I _{OL} =32mA			0.55	
Input Leakage Current	I _(LEAK)	V _{CC} =3.6V, V _{IN} =5.5V or GND			±1	µA
Power OFF leakage current	I _{OFF}	V _{CC} =0V, V _{IN} or V _O =5.5V			±10	µA

■ STATIC CHARACTERISTICS (Cont.)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Quiescent Supply Current	I_Q	$V_{CC}=1.65\sim 5.5V$, $V_{IN}=5.5V$ or GND, $I_{OUT}=0$			1	μA
Additional Quiescent Supply Current	ΔI_Q	One input at $V_{CC}-0.6V$, other inputs at V_{CC} or GND, $V_{CC}=3\sim 5.5V$			500	μA
Input Capacitance	C_{IN}	$V_{CC}=3.3V$, $V_{IN}=V_{CC}$ or GND		3.5		pF

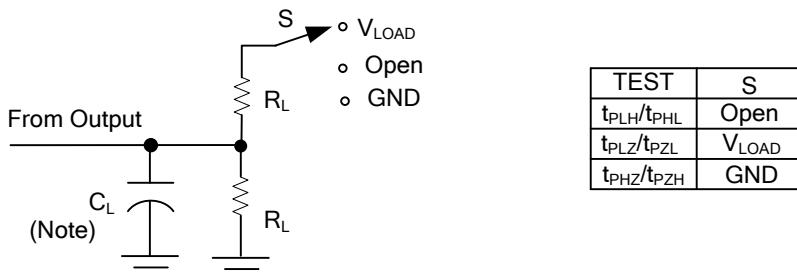
■ DYNAMIC CHARACTERISTICS (Input: $t_R=t_F=6ns$, unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS		MIN	TYP	MAX	UNIT
Propagation delay from Input(nA or nB) to Output(Y)	t_{PLH} / t_{PHL}	$V_{CC}=1.8\pm 0.15V$	$C_L=15pF$, $R_L=1M\Omega$	2		9.9	ns
		$V_{CC}=2.5\pm 0.2V$		1.5		6	
		$V_{CC}=3.3\pm 0.3V$		1		3.5	
		$V_{CC}=5\pm 0.5V$		1		2.9	
		$V_{CC}=1.8\pm 0.15V$	$C_L=15pF$	$R_L=1k\Omega$	3.2		8.6
		$V_{CC}=2.5\pm 0.2V$		$R_L=500\Omega$	1.5		4.4
		$V_{CC}=3.3\pm 0.3V$	$C_L=15pF$	$R_L=500\Omega$	1.5		4.1
		$V_{CC}=5\pm 0.5V$			1		3.2

■ OPERATING CHARACTERISTICS ($f=10MHz$, unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITION	MIN	TYP	MAX	UNIT
Power Dissipation Capacitance	C_{PD}	$V_{CC}=1.8V$		16		pF
		$V_{CC}=2.5V$		16		
		$V_{CC}=3.3V$		16		
		$V_{CC}=5V$		18		

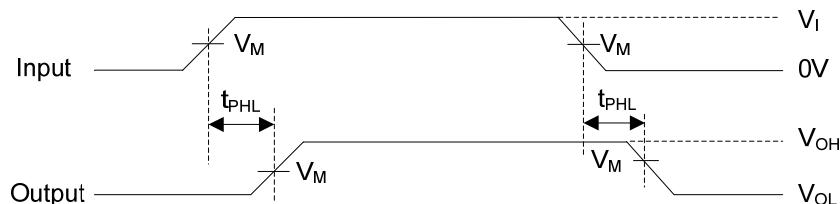
■ TEST CIRCUIT AND WAVEFORMS



TEST CIRCUIT

Note : C_L includes probe and jig capacitance.

V_{CC}	V_{IN}	t_R, t_F	V_M	V_{LOAD}	C_L	R_L	V_Δ
$1.8V \pm 0.15V$	V_{CC}	$\leq 2ns$	$V_{CC}/2$	$2*V_{CC}$	15pF	1MΩ	0.15V
					30pF	1KΩ	
$2.5V \pm 0.2V$	V_{CC}	$\leq 2ns$	$V_{CC}/2$	$2*V_{CC}$	15pF	1MΩ	0.15V
					30pF	500Ω	
$3.3V \pm 0.3V$	3V	$\leq 2.5ns$	1.5V	6V	15pF	1MΩ	0.3V
					50pF	500Ω	
$5V \pm 0.5V$	V_{CC}	$\leq 2.5ns$	$V_{CC}/2$	$2*V_{CC}$	15pF	1MΩ	0.3V
					50pF	500Ω	



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